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INFORMATION DISCLOSURE STATEMENT BY APPLICANT (Use as many sheets as necessary)				Complete If Known	
				Application Number	10/784,786-Conf. #2218
				Filing Date	February 24, 2004
				First Named Inventor	Hasan Nejad
				Art Unit	2827
				Examiner Name	V. Q. Nguyen
Sheet	1	of	1	Attorney Docket Number	M4065.0509/P509 B

U.S. PATENT DOCUMENTS					
Examiner Initials*	Cite No. ¹	Document Number Number-Kind Code ² (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
✓	AA	US-2003/0223292	Dec., 2003	Nejad et al.	
✓	AB	US-5969380	Oct. 1999	Seyedy	
✓	AC	US-6349054	Feb. 2002	Hidaka	
✓	AD	US-6373753	Apr., 2002	Proebsting	
✓	AE	US-6570795	May, 2003	Fricke et al.	
✓	AF	US-6577529	Jun., 2003	Sharma et al.	
✓	AG	US-6631085	Oct., 2003	Kleveland et al.	
✓	AH	US-6671213	Dec. 2003	Ohtani	
✓	AI	US-6680862	Jan., 2004	Hidaka	
✓	AJ	US-6680863	Jan., 2004	Shi et al.	
✓	AK	US-6693825	Feb., 2004	Sharma et al.	
✓	AL	US-6717222	Apr., 2004	Zhang	
✓	AM	US-6724653	Apr., 2004	Iwata et al.	
✓	AN	US-6756652	Jun., 2004	Yano et al.	
✓	AO	US-6778434	Aug., 2004	Tsuji	
✓	AP	US-6829188	Dec., 2004	Baker	
✓	AQ	US-6882553	Apr., 2005	Nejad et al.	

VIET Q. NGUYEN
PRIMARY EXAMINER

FOREIGN PATENT DOCUMENTS					
Examiner Initials*	Cite No. ¹	Foreign Patent Document Country Code ³ -Number ⁴ -Kind Code ⁵ (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
✓	BA	JPO2002170376	Jun., 2002	Hidaka	
✓	BB	WO 000241321	May, 2002	Boehm et al.	

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant. ¹ Applicant's unique citation designation number (optional). ² See Kinds Codes of USPTO Patent Documents at www.uspto.gov or MPEP 901.04. ³ Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). ⁴ For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. ⁵ Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST.16 if possible. ⁶ Applicant is to place a check mark here if English language Translation is attached.

NON PATENT LITERATURE DOCUMENTS			
Examiner Initials*	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T ²

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Examiner Signature	V. Nguyen	Date Considered	6/19/2005
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